Search	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	er
10/608,008	LEE ET AL.	
Examiner	Art Unit	
Dung Nguyen	2871	

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	SEARCHED		
Class	Subclass	Date	Examiner
349	58, 149- 152	10/12/2006	DN
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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